

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/905,436	TELOH ET AL.	
Examiner	Art Unit	
Hieu c. Le	2142	

SEARCHED					
Class	Subclass	Date	Examiner		
709	203	5/9/2005	HL		
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714	6,15				
Updated	searched	5/8/2005	HL		
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